Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/607,029	HAN, CHANG WOOK
Examiner	Art Unit
Kevin Quinto	2826

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
257 /347,72	3/14/04	72		
438/48,128,147,154,157,				
283, 429,517				
(tout limite d- see prished)				
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